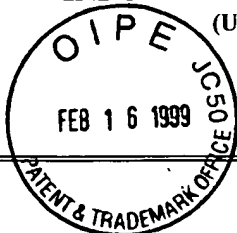


Form PTO-1449 (Rev. 8-83) (modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 11770US03	SERIAL NO. 09/143,503
			APPLICANT(s): Ainsworth, et al.	
			FILING DATE August 28, 1998	GROUP ART UNIT: <del>3734</del> 3763

**INFORMATION DISCLOSURE CITATION**

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**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JY	A1	5,100,381	03/31/92	Burns	604	96	
	A2	5,139,496	08/18/92	Hed	606	23	
	A3	5,176,637	01/00/93	Sagae	604	96	
	A4	5,213,574	05/00/93	Tucker	604	93	
	A5	5,221,728	06/22/93	Bennett et al.	528	125	
	A6	5,258,160	11/00/93	Utsumi et al.	264	558	
	A7	5,259,839	11/09/93	Burns	604	99	
	A8	5,270,086	12/14/93	Hamlin	604	96 X	
	A9	5,304,134	12/00/93	Kraus et al.	604	96	
	A10	5,316,706	05/31/94	Muni et al.	264	25	
	A11	5,344,400	09/06/94	Kaneko et al.	604	96	
	A12	5,423,754	05/13/95	Cornelius et al.	504	103	
	A13	5,531,715	07/02/96	Engelson et al.	604	265	
	A14	5,542,937	08/06/96	Chee et al.	604	280	

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NO.	PUBLICATION DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
JY	B1	0171884	02/00/86	EPO				
	B2	0452595 A1	10/23/91	EPO				
	B3	WO 94/01160	01/20/94	PCT				

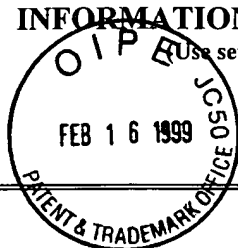
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Form PTO-1449 (Rev. 8-83) (modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. 11770US03	SERIAL NO. 09/143,503
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)		
	C1	Cebe, <i>et al.</i> , "Effect of Thermal History on Mechanical Properties of Polyetheretherketone below the Glass Transition Temperature," <i>Journal of Applied Polymer Science</i> , 33:487-503 (1987)
	C2	Collier <i>et al.</i> , "Processing Conditions and Properties of Semicrystalline Polymers, I: Effect of Mechanical Properties of a Chlorinated Polyether," <i>Polymer Engineering and Science</i> , 11(6):452-462 (November, 1971)
	C3	<i>International Plastics Selector-Plastics Digest</i> , 1994 edition, 2 pages
	C4	Kirk-Othmer Encyclopedia of Chemical Technology, 4th Edition, A Wiley-Interscience Publication John Wiley & Sons, Vol. 9, pp 525-566
	C5	McConnell, "Advanced thermoplastics - Electronics markets hum along while military and aerospace falter," <i>Modern Plastics</i> , pp. 100-103
	C6	<i>Plastics Extrusion Technology Handbook</i> , Second Edition, 1989, 5 pages
	C7	Rigby, "Polyetheretherketone," <i>Engineering Thermoplastics Properties and Applications</i> , Chapter 2, edited by James M. Margolis, Margolis Marketing and Research Company New York, New York. pp.299-314
	C8	Sasuga, <i>et al.</i> , "Degradation in tensile properties of aromatic polymers by electron beam irradiation," <i>Polymer</i> , 26:1039-1045 (1985)
	C9	Talbott, <i>et al.</i> , "The Effects of Crystallinity on the Mechanical Properties of PEEK Polymer and Graphite Fiber Reinforced PEEK," <i>Journal of Composite Materials</i> , 21:1056-1081 (November, 1987)
	C10	<i>Victrix PEEK Properties and Processing</i> , Product Brochure of ICI Advanced Materials 4 pages (1990)

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